Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/670,545	HSIEH ET AL.	
Examiner	Art Unit	
Alford M. Kindrod	2162	

SEARCHED					
Class	Subclass	Date	Examiner		
707	1, 3	11/8/2005	AWK		
705	75-76				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
West US, JPO, EPO, IBM, Derwent	11/8/2005	AWK		
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